

STC (Dongguan) Company Limited EC DECLARATION OF CONFORMITY

Reference Number: EMC-D163132DOC

Intracom Asia Co., Ltd 4F., No.77, Sec.1, Xintai 5th Rd., Xizhi Dist., New Taipei City 221, Taiwan

declare the product

Description: 8-Port Fast Ethernet Office Switch, Plastic

Brand Name: Manhattan Model: 560689

complies with the requirements of the

EC Electromagnetic Compatibility Directive 2014/30/EU

Applicable Standard(s) with amendments:

EN55022: 2010 +AC: 2011

EN55024: 2010 EN61000-3-2: 2014 EN61000-3-3: 2013

General Remarks:

This declaration is only valid when used in conjunction with the technical file(s) refers to DM123142.

This declaration applies specifically to the sample(s) investigated in the technical report mentioned above and not to the bulk.

The CE mark as shown below can be used, under the responsibility of the manufacturer, after completion of an EC Declaration of Conformity and compliance with all relevant EC Directives.

Manufacturer/Importer



Test Laboratory

Signature

LONG van Jian Along
Authorized Signatory
ElectroMagnetic Compatibility Department
For and on behalf of

STC (Dongguan) Company Limited

www.dgstc.org **Date of Issue:** 2016-04-20





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Applicant: Intracom Asia Co., Ltd

4F., No.77, Sec.1, Xintai 5th Rd., Xizhi Dist., New Taipei

City 221, Taiwan

Description of Sample(s): Submitted sample(s) said to be

Product: 8-Port Fast Ethernet Office Switch,

Plastic

Brand Name: Manhattan Model Number: 560689

Date Sample(s) Received: 2014-08-20

Date Tested: 2014-08-25 to 2014-09-25

Investigation Requested: Test for compliance with EMC requirements of EN55022,

EN55024, EN61000-3-2 and EN61000-3-3.

Conclusion(s): The submitted product <u>COMPLIED</u> with the requirements

of EN55022: 2010 +AC: 2011, EN55024: 2010, EN61000-3-2: 2014 and EN61000-3-3: 2013. The EMC tests were performed in accordance with the standards described above and on Section 2.2 in this Test Report.

Remark(s): ----



ElectroMagnetic Compatibility Department For and on behalf of STC (Dongguan) Company Limited



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1.0 General Details

1.1 Equipment Under Test [EUT] Description of Sample(s)

Product: 8-Port Fast Ethernet Office Switch, Plastic

Manufacturer: Intracom Asia Co., Ltd

4F., No.77, Sec.1, Xintai 5th Rd., Xizhi Dist., New Taipei City 221,

Taiwan

Brand Name: Manhattan
Model Number: 560689
Rating: 5Vd.c.with Jack

The AC/DC adaptor was provided by the applicant with following details:-

Brand name: N/A; Model no.: AMS20-0501000FV2; Input: 100-240Va.c. 50/60Hz 0.2A,

Output: 5Vd.c. 1.0A.

1.1.1 Description of EUT Operation

The Equipment Under Test (EUT) is a 8-Port Fast Ethernet Office Switch, Plastic of Intracom Asia Co., Ltd. Test was conducted under the Data transfer mode to simulate the normal operating condition. Port 1 and 8 of the EUT were connected to two PC which operated with ping the IP address to each other.

1.2 Date of Order

2014-08-20

1.3 Submitted Sample(s):

1 Sample

1.4 Test Duration

2014-08-25 to 2014-09-25

1.5 Country of Origin

China



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2.0 Technical Details

2.1 Investigations Requested

Perform ElectroMagnetic Interference [EMI] & ElectroMagnetic Susceptibility [EMS] tests for CE Marking

2.2 Test Standards and Results Summary Tables

Test Standards					
EN55022: 2010	Information technology equipment - Radio disturbance characteristics -				
+AC: 2011	Limits and methods of measurement				
EN55024: 2010	Information technology equipment - Immunity characteristics - Limits and				
	methods of measurement				
EN61000-3-2: 2014	Electromagnetic compatibility (EMC) - Part 3-2: Limits - Limits for				
	harmonic current emissions (equipment input current ≤16 A per phase)				
EN61000-3-3: 2013	Electromagnetic compatibility (EMC) - Part 3-3: Limits - Limitation of				
	voltage changes, voltage fluctuations and flicker in public low-voltage				
	supply systems, for equipment with rated current ≤16 A per phase and not				
	subject to conditional connection				



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2.2 Test Standards and Results Summary Tables

EMISSION Results Summary							
Test Condition	Test Requirement	Test Method	Class /	To	est Result		
			Severity	Pass	Failed	N/A	
Radiated Emission,	EN55022: 2010	EN55022: 2010	Class B	\boxtimes			
30MHz to 1GHz	+AC: 2011	+AC: 2011					
Conducted Emission	EN55022: 2010	EN55022: 2010	Class B	\boxtimes			
on AC, 150kHz to	+AC: 2011	+AC: 2011					
30MHz							
Harmonic Emissions	EN61000-3-2: 2014	EN61000-3-2: 2014	Class A	\boxtimes			
on AC Supply							
Voltage Fluctuations	EN61000-3-3: 2013	EN61000-3-3: 2013	N/A	\boxtimes			
on AC Supply							



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2.2 Test Standards and Results Summary Tables

SUSCEPTIBILITY Results Summary							
Test Condition	Test Requirement	Test Method	Class /	Т	est Result		
	1		Severity	Pass	Failed	N/A	
Electrostatic Discharge	EN55024: 2010	EN61000-4-2: 2009	±2.0kV, ±4.0kV Cont ±2.0kV, ±4.0kV, ±8.0kV Air				
Radiated Immunity 80MHz to 1000MHz	EN55024: 2010	EN61000-4-3: 2006 +A1:: 2008 +A2: 2010	3V/m				
Electrical Fast Transients on AC Supply	EN55024: 2010	EN61000-4-4: 2004	±1.0kV	\boxtimes			
Electrical Fast Transients on LAN Port	EN55024: 2010	EN61000-4-4: 2004	±0.5kV				
Surge Immunity on AC Supply	EN55024: 2010	EN61000-4-5: 2006	±0.5kV ±1.0kV				
Surge Immunity on LAN Port	EN55024: 2010	EN61000-4-5: 2006	±1.0kV	\boxtimes			
Continuous RF Immunity on AC Supply	EN55024: 2010	EN61000-4-6: 2009	3Vrms				
Continuous RF Immunity on LAN Port	EN55024: 2010	EN61000-4-6: 2009	3Vrms	\boxtimes			
Voltage Dips, Interruptions and Variations on AC Supply	EN55024: 2010	EN61000-4-11: 2004	0%, 70% of U _T				
Power Frequency Magnetic Field	EN61000-6-1: 2007	EN61000-4-8: 1993	3A/m (r.m.s)				

Remarks:

N/A: Not Applicable

U_{T:} The nominal supply voltage



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3.0 Test Results

3.1 Emission

3.1.1 Radiated Emissions (30MHz to 6000MHz)

Test Requirement: EN 55022
Test Method: EN 55022
Level: Class B

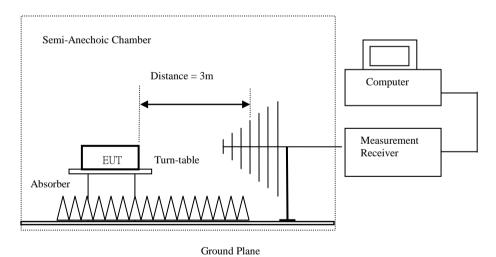
Test Date(s): 2014-08-25

Mode of Operation: Data transfer mode

Test Method:

The test was performed in accordance with EN55022 at 3m test distance on a standard emission test site, with quasi-peak measurements performed if the maximised peak measurements were less than 6dB from the corresponding Class B limit lines.

Test Setup:



Absorbers placed on top of the ground plane are for measurements above 1000MHz only.



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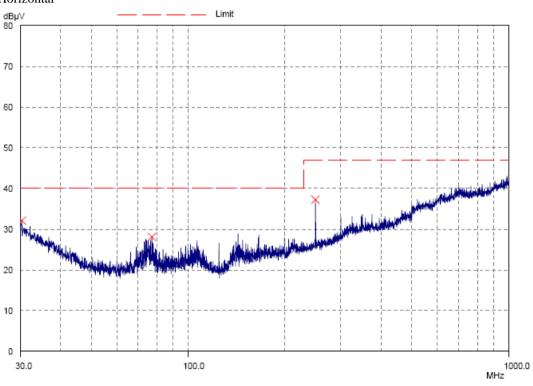
Limits for Radiated Emission:

Emits for Radiated Emission.	
Frequency Range	Quasi-Peak Limits
[MHz]	$[dB\mu V/m]$
30-230	40.0
230-1000	47.0

Results of Data transfer mode (connected to PC): Pass

Please refer to the following table for result details

Horizontal



The quasi-peak measurements were recorded as follows:

Frequency	Level @3m	Limit @3m	Margin	E-Field Polarity
MHz	dBµV/m	$dB\mu V/m$	dB	
30.4	30.1	40.0	9.9	Horizontal
77.3	26.1	40.0	13.9	Horizontal
250.0	36.8	47.0	10.2	Horizontal



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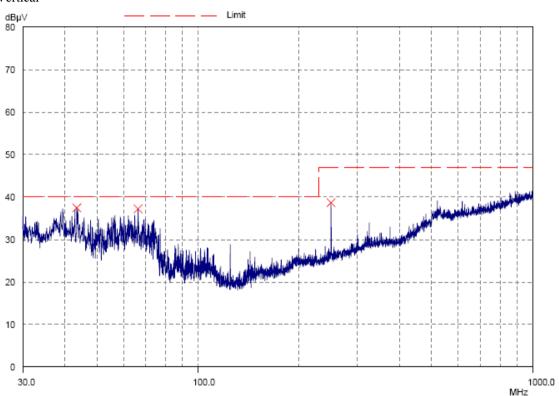
Limits for Radiated Emission:

Elimis for Rudiuced Elimssion.	
Frequency Range	Quasi-Peak Limits
[MHz]	$[dB\mu V/m]$
30-230	40.0
230-1000	47.0

Results of Data transfer mode (connected to PC): Pass

Please refer to the following table for result details

Vertical



The quasi-peak measurements were recorded as follows:

Frequency	Level @3m	Limit @3m	Margin	E-Field Polarity
MHz	$dB\mu V/m$	$dB\mu V/m$	dB	
43.5	35.4	40.0	4.6	Vertical
66.3	35.2	40.0	4.8	Vertical
250.0	37.8	47.0	9.2	Vertical

Remark:

Calculated measurement uncertainty (30MHz - 1GHz): 4.6dB

Emissions in the vertical and horizontal polarizations have been investigated and the worst-case test results are recorded in this report.



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3.1.2 Conducted Emissions (150kHz to 30MHz)

Test Requirement: EN 55022
Test Method: EN 55022
Level: Class B

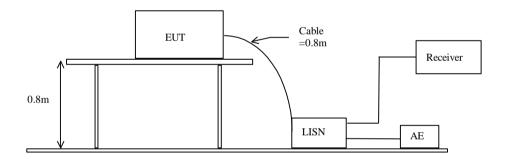
Test Date(s): 2014-08-25

Mode of Operation: Data transfer mode

Test Method:

Initial measurements were performed in peak and average detection modes on the live line. Any emissions recorded within 30dB of the relevant limit lines were re-measured using quasi-peak and average detection on the live and neutral lines with the worst case recorded in the table of results. The test was performed in accordance with EN 55022.

Test Setup:





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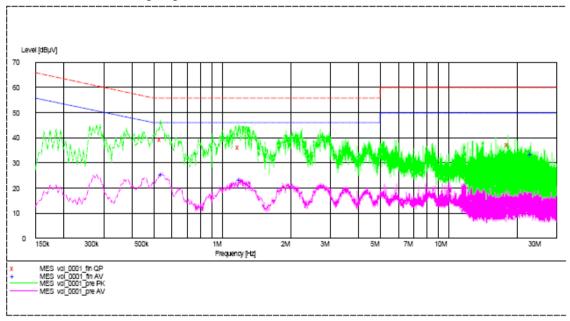
No.: DM123142

Results and limit lines for Conducted Emission:

Limits for Conducted Emission Test, please refer to limit lines (Quasi-Peak and Average) in the following diagram.

Results of Data transfer mode (connected to PC) (L): Pass

Please refer to the following diagram for individual results.



MEASUREMENT RESULT: "vol 0001 fin AV"

					53PM	8/25/2014 3:5
PE	Line	Margin	Limit	Transd	Level	Frequency
		dB	dΒμV	dB	dΒμV	MHz
GND	T.1	20.5	46	9.6	25.50	0.545000
		22.6		9.6		
						23.130000
01.2						MEASUREMENT RE
			-			
					53PM	8/25/2014 3:5
PE	Line	Margin	Limit	Transd	Level	Frequency
		dB	dΒμV	dB	dΒμV	MHz
GND	Ll	16.6	56	9.6	39.40	0.535000
GND	Ll	19.7	56	9.6	36.30	1.185000
GND	Ll	22.7	60	9.9	37.30	18.365000



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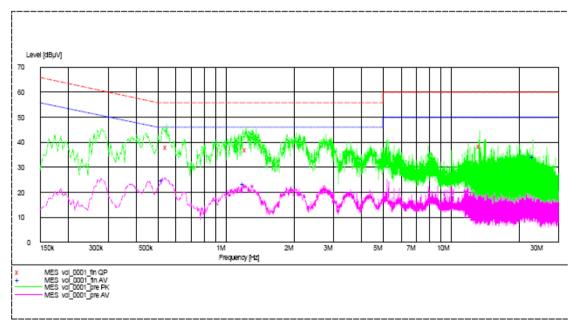
No.: DM123142

Results and limit lines for Conducted Emission:

Limits for Conducted Emission Test, please refer to limit lines (Quasi-Peak and Average) in the following diagram.

Results of Data transfer mode (connected to PC) (N): Pass

Please refer to the following diagram for individual results.



MEASUREMENT RESULT: "vol 0001 fin AV"

8/25/2014 3 Frequency MHz	Level	Transd dB	Limit dBµV	Margin dB	Line	PE
0.525000 1.200000 23.130000 MEASUREMENT	23.30 34.30		50	22.7 15.7		GND GND GND
8/25/2014 3 Frequency MHz	Level	Transd dB	Limit dBµV	Margin dB	Line	PE
0.550000 1.235000 13.420000	36.90	9.6 9.6 9.8	56 56 60		N N N	GND GND GND



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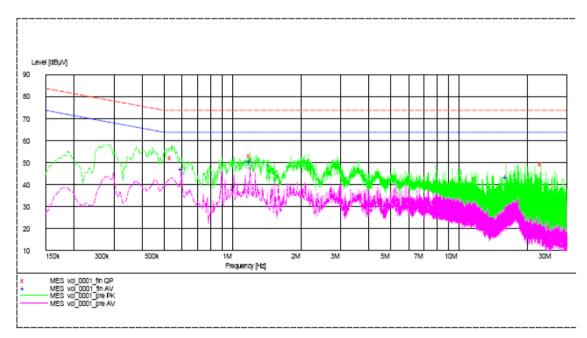
No.: DM123142

Results and limit lines for Conducted Emission:

Limits for Conducted Emission Test, please refer to limit lines (Quasi-Peak and Average) in the following diagram.

Results of Data transfer mode (connected to PC, LAN1): Pass

Please refer to the following diagram for individual results.



MEASUREMENT RESULT: "vol 0001 fin AV"

PE	Line	Margin dB	Limit dBµV			8/26/2014 10: Frequency MHz
		13.3	64 64	9.6 9.6 9.8 rol_0001_		0.600000 1.200000 16.230000 MEASUREMENT RE
PE	Line	Margin dB	Limit dBµV		Level	8/26/2014 10: Frequency MHz
		21.7 21.1 24.6	74 74 74	9.6 9.6 10.0	52.30 52.90 49.40	0.540000 1.200000 23.130000



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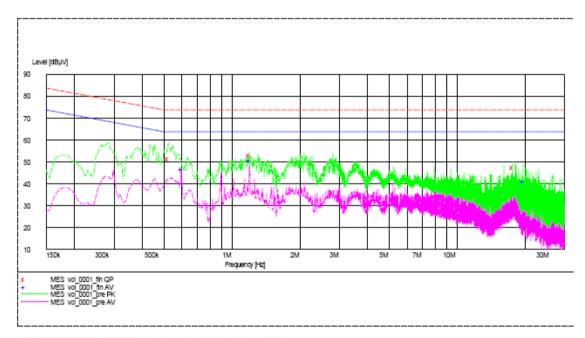
No.: DM123142

Results and limit lines for Conducted Emission:

Limits for Conducted Emission Test, please refer to limit lines (Quasi-Peak and Average) in the following diagram.

Results of Data transfer mode (connected to PC, LAN8): Pass

Please refer to the following diagram for individual results.



MEASUREMENT RESULT: "vol_0001_fin AV"

					:57AM	8/26/2014 10:
PΕ	Line	Margin	Limit	Transd	Level	Frequency
		dB	dBuV	dB	dΒμV	MHz
					-	
		17.1	64	9.6	46.90	0.600000
		13.3	64	9.6	50.70	1.200000
		22.8	64	9.9	41.20	19.710000
		*	fin QP'	rol 0001	ESULT: "v	MEASUREMENT RE
			-			
					57AM	8/26/2014 10:
PE	Line	Margin	Limit	Transd	Level	Frequency
		dB	dBuV		dBuV	MHz
		GL.	αυμν	QD.	αυμν	11112
		22.6	74	9.6	51.40	0.525000
			74	9.6		
					52.90	
		26.6	74	9.9	47.40	17.695000

Remark:

Calculated measurement uncertainty (0.15MHz - 30MHz): 3.2dB



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3.1.3 Harmonics Emissions on AC Supply

Test Requirement: EN 61000-3-2
Test Method: EN 61000-3-2
Level: Class A

Test Date(s): 2014-08-27

Mode of Operation: Data transfer mode

Input Voltage: 230Va.c.

Test Method:

The test was performed in accordance with EN 61000-3-2.



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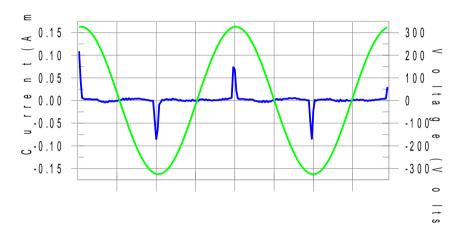
Results and limit line for Harmonics Emissions:

For limits for Harmonics Emission Test, please refer to limit lines (saw-tooth) in the following diagram.

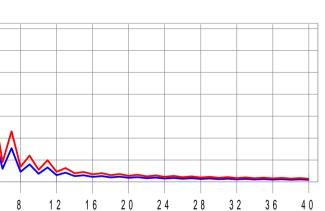
Results: Pass

Please refer to the following table for individual results.

Current & voltage waveforms



Harmonics and Class A limit line European Limits



Harmonic #

Remark:

3.5 ≥3.0 2.5 -2.0 •1.5 -1.0 -0.5 0.0

Calculated measurement uncertainty: 7.1%



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3.1.4 Emission for Fluctuations & Flicker

Test Requirement: EN 61000-3-3 Test Method: EN 61000-3-3

Level: N/A

Test Date(s): 2014-08-27

Mode of Operation: Data transfer mode

Test Method:

The test was performed in accordance with EN 61000-3-3.



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Limits for Flicker:

Please refer to the result table for details.

Results: Pass

Please refer to the following table for individual results.

Maximum Occurring Levels:

Pst:	0.064	Limit =	1.00	(The Highest Short Term Flicker Value)
Plt:	0.028	Limit =	0.65	(The Highest Long Term Flicker Value)
dc(%):	0.00	Limit =	3.30%	(The Highest Relative Steady State Voltage Change (1sec))
dmax:	0.00	Limit =	4.00%	(*The Highest Maximum Relative Voltage Change)
Tdt:	0.00	Limit =	500ms	(The Max Time (in milli-sec) that dt exceeds 3.3%)
Ut:	230.15V			(EUT Test RMS Voltage)

Remark:

^{* -} Some products may have more relax limits (refer to Clause 5 of EN 61000-3-3) Calculated measurement uncertainty: 7.7%



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3.2 Immunity

3.2.1 Susceptibility Performance Criteria

A	Normal performance within the specification limits
В	Temporary degradation or loss of function or performance which is self-
	recoverable
С	Temporary degradation or loss of function or performance which
	requires operator intervention or system reset
D	Degradation or loss of function which is not recoverable due to damage of
	equipment (components) or software, or loss of data



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3.2.2 Electrostatic Discharge

Test Requirement: EN 55024 Test Method: EN 61000-4-2

Severity: $\pm 2kV$, $\pm 4kV$ for Direct & Indirect Contact Discharge

±2kV, ±4kV, ±8kV for Air Discharge

Performance Criterion Requirement: B

Temperature: 22 °C Humidity: 54 % Atmospheric Pressure: 101 kPa

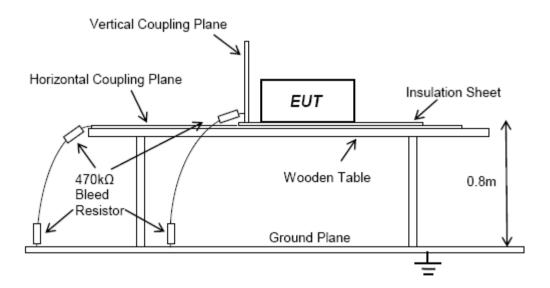
Test Date(s): 2014-08-29

Mode of Operation: Data transfer mode

Test Method:

The test was performed in accordance with EN 61000-4-2.

Test Setup:





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Severity Levels for Electrostatic Discharge:

Severity Devels for Electrostatic Discharge.						
Level	Test Voltage	Test Voltage				
	Direct & Indirect Contact Discharge	Air Discharge				
	[kV]	[kV]				
1	±2kV	±2kV				
2	±4kV	±4kV				
3	±6kV	±8kV				
4	±8kV	±15kV				

Results of Data transfer mode: Pass

Please refer to the following table for individual results.

Location		D: 1 M.(1 1	T AVI	Individual Results	
		Discharge Method	Test Voltage	Pass	Failed
HCP	[Horizontal Coupling Plane]	Indirect Contact	±2kV, ±4kV	\boxtimes	
VCP	[Vertical Coupling Plane]	Indirect Contact	±2kV, ±4kV	\boxtimes	
Gaps		Air	±2kV, ±4kV, ±8kV	\boxtimes	
LAN po	ort/ DC Port	Air	±2kV, ±4kV, ±8kV	\boxtimes	

***EUT Grounding	Grounded	☑ Ungrounded
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Remarks:

***For ungrounded EUT, the charge on the EUT shall be removed prior to each applied ESD pulse Calculated measurement uncertainty: 7.1%



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3.2.3 Radiated Immunity [80MHz to 1000MHz]

Test Requirement: EN 55024
Test Method: EN 61000-4-3
Severity: Level 2 [3V/m]
Modulation: 80% 1kHz AM

Performance Criterion Requirement: A

Temperature: 24 °C Humidity: 52 %

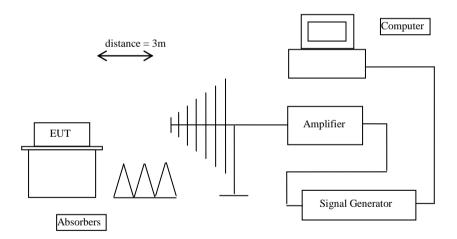
Test Date(s): 2014-08-28

Mode of Operation: Data transfer mode

Test Method:

The test was performed in accordance with EN 61000-4-3.

Test Setup:





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Severity Levels for Radiated Immunity:

Level	Field Strength [V/m]
1	1
2	3
3	10

Results of Data transfer mode: Pass

Please refer to the following table for individual results.

Frequency	Face	Polarity	Level	Dwell Time	Sweep rate		vidual sults
(MHz)			(V/m)	(s)	(%)	Pass	Failed
80-1000	0°	Horizontal	3	3	1	\boxtimes	
80-1000	90°	Horizontal	3	3	1	\boxtimes	
80-1000	180°	Horizontal	3	3	1	\boxtimes	
80-1000	270°	Horizontal	3	3	1	\boxtimes	
80-1000	$0_{\rm o}$	Vertical	3	3	1	\boxtimes	
80-1000	90°	Vertical	3	3	1	\boxtimes	
80-1000	180°	Vertical	3	3	1	\boxtimes	
80-1000	270°	Vertical	3	3	1	\boxtimes	

Remarks:

The dwell time at each frequency is according to the standard being applied and the basic standard Calculated measurement uncertainty: 1.74dB



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3.2.4 Electrical Fast Transients on AC Supply / LAN Port

Test Requirement: EN 55024
Test Method: EN 61000-4-4

Severity: Level 2 on LAN Port $[\pm 0.5kV]$

Level 2 on AC [±1kV]

Performance Criterion Requirement: B

Temperature: 24 °C Humidity: 52 % Atmospheric Pressure: 101 kPa

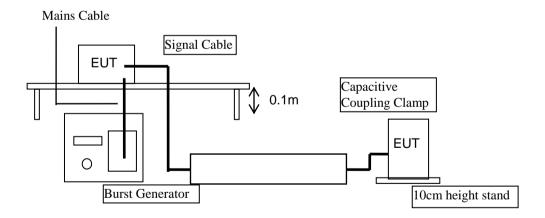
Test Date(s): 2014-08-27

Mode of Operation: Data transfer mode

Test Method:

The test was performed in accordance with EN 61000-4-4.

Test Setup:





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Severity Levels for Electrical Fast Transient:

Level	On power supply port, PE		On I/O (Input/Output) signal, data and control ports		
	Voltage peak Repetition rate		Voltage peak	Repetition rate	
	[kV] [kHz]		[kV]	[kHz]	
1	0.5	5.0	0.25	5.0	
2	1.0	5.0	0.50	5.0	
3	2.0	5.0	1.00	5.0	
4	4.0	2.5	2.00	5.0	

Results of Data transfer mode: Pass

Please refer to the following table for individual results.

Conductor	Polarity & Level	Duration/Polarity Individual F		al Results
		(s)	Pass	Failed
LAN Port	±0.5kV	120	\boxtimes	
Live- Neutral	±1kV	120	\boxtimes	

Remark:

Calculated measurement uncertainty: 7.1%



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3.2.5 Surge Immunity on AC Supply / LAN Port

Test Requirement: EN 55024
Test Method: EN 61000-4-5

Severity: On AC:

Level 1 - ± 0.5 kV (between live & neutral) Level 2 - ± 1.0 kV (between live & neutral)

On LAN ports:

Level 2 - ±1.0kV (LAN port)

Performance Criterion Requirement: B for AC Supply

C for LAN ports

Temperature: 21 °C Humidity: 48 % Atmospheric Pressure: 101 kPa

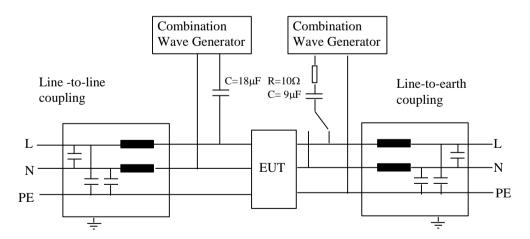
Test Date(s): 2014-08-29 to 2014-09-25

Mode of Operation: Data transfer mode

Test Method:

The test was performed in accordance with EN 61000-4-5.

Test Setup:





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Severity Levels for Surge Immunity:

Level	Open-circuit test voltage ±10% kV
1	0.5
2	1.0
3	2.0
4	4.0

Results of Data transfer mode: Pass

Please refer to the following table for individual results

Conductor	Level & Polarity	No. of	Phase	Surge	Individua	al Results
	kV	Surge	Angle	Interval (s)	Pass	Failed
			$0_{\rm o}$		\boxtimes	
Live - Neutral	$\pm 0.5, \pm 1.0$	5	90°	60s	\boxtimes	
			180°		\boxtimes	
			270°		\boxtimes	
LAN Port	±1.0kV	5		60s	\boxtimes	

Remarks:

*- N/A: Not Applicable

Calculated measurement uncertainty: 7.1%



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3.2.6 Continuous RF Immunity on AC Supply / LAN Port (150kHz to 80MHz)

Test Requirement: EN 55024
Test Method: EN 61000-4-6

Severity: Level 2 - 3Vrms(emf) with 80% 1kHz AM

Performance Criterion Requirement: A

Temperature: 24 °C Humidity: 52 % Atmospheric Pressure: 101 kPa

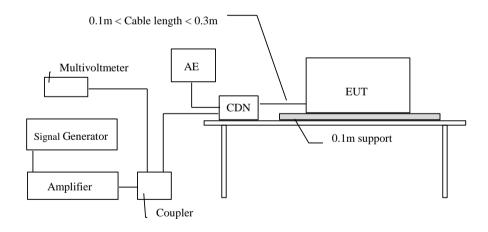
Test Date(s): 2014-08-28

Mode of Operation: Data transfer mode

Test Method:

The test was performed in accordance with EN 61000-4-6.

Test Setup:





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Severity Levels for Continuous RF Immunity:

Frequency range 150kHz - 80MHz					
Level Voltage level (emf)					
	$U_{o} [dB(\mu V)]$ $U_{o} [V]$				
1	120	1			
2	130	3			
3	3 140 10				

Results of Data transfer mode: Pass

Please refer to the following table for individual results.

Frequency	Level	Dwell Time	Sweep rate	Individual Results	
(MHz)	(Vrms)	(s)	(%)	Pass	Failed
150kHz – 80MHz	3	3	1	\boxtimes	

Remark:

Calculated measurement uncertainty: 2.39dB



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3.2.7 Voltage Dips, Interruptions and Variations on AC Supply

Test Requirement: EN 55024 EN 61000-4-11 Severity: [0, 70]% of U_T

Performance Criterion Requirement: B for 0% of U_T for 0.5 period

C for other specifications

Temperature: 23 °C Humidity: 53 % Atmospheric Pressure: 101 kPa

Test Date(s): 2014-08-28

Mode of Operation: Data transfer mode

Test Method:

The test was performed in accordance with EN 61000-4-11.



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Severity Levels for voltage dips, short interruptions and voltage variations immunity:

Level	Voltage dip and short interruptions	Duration (period)
0	100	0.5
70	30	25
0	100	250

Results of Data transfer mode: Pass

Please refer to the following table for individual results.

Phase	Test Level	Duration	Individual Results	
	(% of U _T)	(period)	Pass	Failed
0° followed by 180°	0	0.5	\boxtimes	
0° followed by 180°	70	25		
0° followed by 180°	0	250	\boxtimes	

Remarks:

Calculated measurement uncertainty: 7.1% of tested voltage

 U_T - The nominal supply voltage



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3.2.8 Power Frequency Magnetic Field

Test Requirement: EN 61000-6-1
Test Method: EN 61000-4-8
Severity: 3A/m (r.m.s)

Performance Criterion Requirement: A

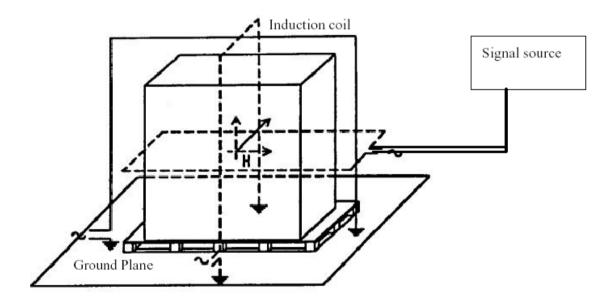
Temperature: 24 °C Humidity: 51 % Atmospheric Pressure: 101 kPa

Test Date(s): 2014-08-28

Mode of Operation: Data transfer mode

Test Method:

The test was performed in accordance with EN 61000-4-8





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Severity Levels for Power Frequency Magnetic Field:

Level	Magnetic filed strength A/m
1	1
2	3
3	10
4	30
5	100
$X^{1)}$	special
NOTE 1 "X" is an open level. This level ca	an be given in the product specification

Results of Data transfer mode: Pass

Please refer to the following table for individual results.

Test Level	EUT Orientation	Individual Results		
		Pass	Failed	
1 A/m	X, Y, Z	\boxtimes		

Remark:

Calculated measurement uncertainty: 7.1%

*****End of Test Report****



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List of Measurement Equipment

RADIATED EMISSION

EQP NO.	DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	LAST CAL
EMD036	EMI Test Receiver	ROHDE & SCHWARZ	ESIB26	100388	2014.06.10
EMD061	BICONILOG ANTENNA	ETS.LINDGREN	3142C	00060439	2012.11.28
EMD084	MULTI-DVICE CONTROLLER	ETS.LINDGREN	2090	00060107	N/A
EMD088	VIDEO CONTOL UNIT	ETS.LINDGREN	Y21953A	2601073	N/A
EMD093	MONITOR	VIEWSONIC	VA9036	Q8X064201876	N/A
EMD102	INTELLIGENT FREQUENCY	AINUO LNSTRUMENT CO., LTD	AN97005SS	79707454	N/A
EMD105	FACT-3 EMC CHAMBER	ETS.LINDGREN	FACT-3	3803	N/A

CONDUCTED EMISSION

EQP NO.	DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	LAST CAL
EMD002	EMI Test Receiver	ROHDE & SCHWARZ	ESHS 10	8468601002	2014.03.21
EMD003	IMPULSEGRENZER PULSE LIMITER	ROHDE & SCHWARZ	ESH3-Z2	100071	2014.03.21
EMD004	ZWEILEITER-V- NETZNACHBILDUNG TWO- LINE V-NETWORK	ROHDE & SCHWARZ	ESH3-Z5	100102	2014.03.21
EMD009	Passive Voltage Probe	ROHDE & SCHWARZ	ESH2-Z3	100020	2014.03.21
EMD022	EMI Test Receiver	ROHDE & SCHWARZ	ESCS 30	100314	2014.03.21
EMD036	EMI Test Receiver	ROHDE & SCHWARZ	ESIB26	100388	2014.06.10
EMD041	TWO-LINE V-NETWORK	ROHDE & SCHWARZ	ENV216	100261	2014.03.21
EMD056	4-WIRE ISN	ROHDE & SCHWARZ	ENY41	100205	2014.06.10
EMD103	Intelligent Frequency	Ainuo Instrument Co., Ltd	AN97005SS	79707455	N/A
EMD106	Shielding Room #1	ETS.LINDGREN	RFD-100	3802	N/A

HARMONICS/FLICKER

EQP NO.	DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	LAST CAL
EMD013	AC POWER SOURCE	SCHAFFNER	NSG1007	54964	2014.03.21
EMD014	HARMONIC & FLICKER METER	SCHAFFNER	CCN1000	72104	2014.06.10

RADIATED FIELD IMMUNITY

EQP NO.	DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	LAST CAL
EMD111	Power meter	ROHDE & SCHWARZ	NRVD	102051	2014.03.21
EMD137	Signal Generator	ROHDE & SCHWARZ	SMB100A	1406600K02- 104532-DF	2014.06.10
EMD060	Biconilog Antenna	ETS.LINDGREN	3142C	00060445	2012.11.03
EMD063	Power Amplifier	BONN ELEKTRONIK	BLWA0840- 50/30D	066454B	2014.03.21
EMD064	Power Amplifier	BONN ELEKTRONIK	BLWA0810- 250/100D	066454A	2014.03.21



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List of Measurement Equipment

ELECTRO STATIC DISCHARGE

EQP NO.	DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	LAST CAL
EMD007	HIGH VOLTAGE OUTPUT ±30KV MAX	KIKUSUI	KES4021	LG001717	2014.01.02
EMD034	DEHUMIDIFIER	KAWASIMA ELECTRICAL APPLIANCE CO.,LTD	DH-820H	N/A	N/A
EMD100	THERMOHYGROGRAPH	SATO KEIRYOKI MFG.CO.,LTD.	7210-00	1633581	2013.08.22
EMD109	BAROGRAPH	SATO KEIRYOKI MFG.CO.,LTD.	NSII-BQ	567719	2013.01.25

EFT/BURST

EQP NO.	DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	LAST CAL
EMD053	TRANSIENT IMMUNITY TEST SYSTEM	EMC-PARTNER	TRANSIENT2000	845	2014.06.10

SURGE IMMUNITY

EQP NO.	DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	LAST CAL
EMD053	TRANSIENT IMMUNITY TEST	EMC-PARTNER	TRANSIENT2000	845	2014.06.10
	SYSTEM				

POWER FREQUENCY MAGNETIC FIELD

EQP NO.	DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	LAST CAL
EMD053	Transient Immunity Test System	EMC-PARTNER	TRANSIENT2000	845	2014.06.10

INJECTED CURRENT IMMUNITY

EQP NO.	DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	LAST CAL
EMD023	DUAL DIRECTIONAL COUPLER	AMPLIFIER RESEARCH	DC2600A	308682	2014.03.21
EMD024	AMPLIFIER	AMPLIFIER RESEARCH	75A250A	308682	2014.03.21
EMD111	POWER METER	ROHDE & SCHWARZ	NRVD	102051	2014.03.21
EMD026	SIGNAL GENERATOR	ROHDE & SCHWARZ	SML01	102439	2014.03.21
EMD029	COUPLING DECOUPLING NETWORK	FISCHER CUSTOM COMMUNICATIONS INC	30W1000B	4022	2014.03.21

VOLTAGE DIP

EQP NO.	DESCRIPTION	MANUFACTURER	MODEL NO.	SERIAL NO.	LAST CAL
EMD053	TRANSIENT IMMUNITY TEST SYSTEM	EMC-PARTNER	TRANSIENT2000	845	2014.06.10

Remark:

N/A Not Applicable



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PHOTOGRAPH (S) OF PRODUCT

Front View of The Product



Rear View of The Product

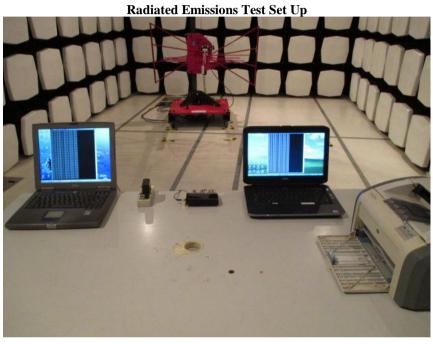


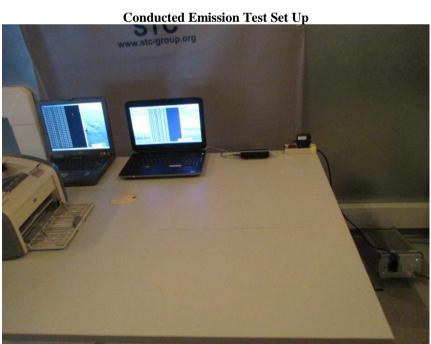


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PHOTOGRAPH (S) OF PRODUCT







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PHOTOGRAPH (S) OF PRODUCT

Harmonic Emissions & Voltage Fluctuations Test Set Up



Electro Static Discharge Test Set Up

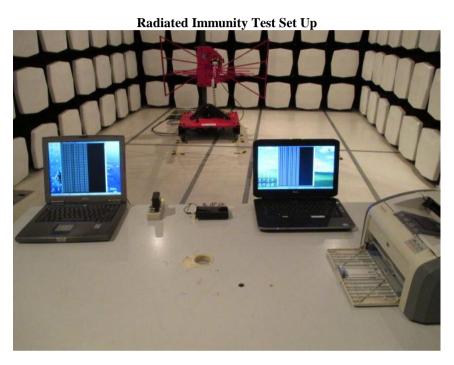




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PHOTOGRAPH (S) OF PRODUCT



Electrical Fast Transients, Surge Immunity, Voltage Dips Test Set Up





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PHOTOGRAPH (S) OF PRODUCT

Continuous RF Immunity Test Set Up



Power Frequency Test Set Up





Conditions of Issuance of Test Reports

- 1. All samples and goods are accepted by The Hong Kong Standards & Testing Centre Limited (the "Company") solely for testing and reporting in accordance with the following terms and conditions. The Company provides its services on the basis that such terms and conditions constitute express agreement between the Company and any person, firm or company requesting its services (the "Clients").
- 2. Any report issued by the Company as a result of this application for testing service (the "Report") shall be issued in confidence to the Clients and the Report will be strictly treated as such by the Company. It may not be reproduced either in its entirety or in part and it may not be used for advertising or other unauthorized purposes without the written consent of the Company. The Clients to whom the Report is issued may, however, show or send it, or a certified copy thereof prepared by the Company to his customer, supplier or other persons directly concerned. The Company will not, without the consent of the Clients, enter into any discussion or correspondence with any third party concerning the contents of the Report, unless required by the relevant governmental authorities, laws or court orders.
- 3. The Company shall not be called or be liable to be called to give evidence or testimony on the Report in a court of law without its prior written consent, unless required by the relevant governmental authorities, laws or court orders.
- 4. The Report refers only to the sample tested and does not apply to the bulk, unless the sampling has been carried out by the Company and is stated as such in the Report.
- 5. In the event of the improper use the report as determined by the Company, the Company reserves the right to withdraw it, and to adopt any other additional remedies which may be appropriate.
- 6. Sample submitted for testing are accepted on the understanding that the Report issued cannot form the basis of, or be the instrument for, any legal action against the Company.
- 7. The Company will not be liable for or accept responsibility for any loss or damage howsoever arising from the use of information contained in any of its Reports or in any communication whatsoever about its said tests or investigations.
- 8. Clients wishing to use the Report in court proceedings or arbitration shall inform the Company to that effect prior to submitting the sample for testing.
- 9. Subject to the variable length of retention time for test data and report stored hereinto as to otherwise specifically required by individual accreditation authorities, the Company will only keep the supporting test data and information of this test report for a period of three years. The data and information will be disposed of after the aforementioned retention period has elapsed. Under no circumstances shall we provide any data and information which has been disposed of after the retention period. Under no circumstances shall we be liable for damages of any kind, including (but not limited to) compensatory damages, lost profits, lost data, or any form of special, incidental, indirect, consequential or punitive damages of any kind, whether based on breach of contract of warranty, tort (including negligence), product liability or otherwise, even if we are informed in advance of the possibility of such damages.
- 10. Issuance records of the Report are available on the internet at www.stc-group.org. Further enquiry of validity or verification of the Reports should be addressed to the Company.